

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/669,445 | Applicant(s)/Patent Under Reexamination KIM ET AL. | |
| | Examiner Eric B. Compton | Art Unit 3726 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| * | A | US-4,423,607 | 01-1984 | Munini, Dino | 68/23.2 |
| * | B | US-5,329,791 | 07-1994 | Cargnel et al. | 68/24 |
| * | C | US-5,778,703 | 07-1998 | Imai et al. | 68/12.02 |
| * | D | US-6,626,014 | 09-2003 | Heyder et al. | 68/140 |
| * | E | US-6,681,602 | 01-2004 | Heyder et al. | 68/140 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|---------|----------------|
| | N | 2202867 | 05-1988 | GB | Faini | |
| | O | 4341832 | 06-1995 | DE | Altmann | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.